

AP20 Rec'd PCTO 18 MAY 2006

PTO/SB08a/b (07-05)

Approved for use through 07/31/2006. OMB 0651-0031

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Substitute for form 1449A/B/PTO			Complete if Known		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)			Application Number	Not Yet Assigned	
			Filing Date	Concurrently Herewith	
			First Named Inventor	Paul Meredith	
			Art Unit	N/A	
			Examiner Name	Not Yet Assigned	
Sheet	1	of	1	Attorney Docket Number	6106-000006/US/NP

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/A W/	AA*	US-6,599,976-B1	07-29-2003	KOBAYASHI et al	
/A W/	AB*	US-6,403,183-B1	06-11-2002	IWAMIYA et al	
/A W/	AC*	US-6,291,697-B1	09-18-2001	TANAKA et al	
/A W/	AD*	US-6,099,911*	08-08-2000	YANO et al	
/A W/	AE*	US-6,511,721**	01-28-2003	MURATA et al	

FOREIGN PATENT DOCUMENTS							
Examiner Initials ¹	Cite No. ²	Foreign Patent Document		Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³	Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY			
A W	BA	EP-834488-A*		04-08-1998			✓
A W	BB	EP-1074859-A**		02-07-2001			✓
A W	BC	JP-10-226767		08-25-1998			✓
A W	BD	JP-10-316934		12-02-1998			✓
A W	BE	JP-08-120225		05-14-1996			✓
A W	BF	JP-04-180977		06-29-1992			✓

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. * CITE NO.: Those application(s) which are marked with an asterisk (*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. * Applicant's unique citation designation number (optional). * See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 601.04. * Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). * For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. * Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.18 if possible. * Applicant is to place a check mark here if English language Translation is attached.

* EP-834488-A corresponds to US-6,099,911

**EP-1074859-A corresponds to US-6,511,721

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
/A W/	CA	ISHINO et al., "Mass production of hydrophobic silica aerogel and readout optics of Cherenkov light", Nuclear Instruments and Methods in Physics Research A 457 (2001) pp 581-587.	

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Examiner Signature	/Alexander Weddle/	Date Considered	08/18/2009
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